
**Electrochemical impedance
spectroscopy (EIS) on coated and
uncoated metallic specimens —**

**Part 3:
Processing and analysis of data from
dummy cells**

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*Spectroscopie d'impédance électrochimique (SIE) sur des éprouvettes
métalliques revêtues et non revêtues —*

*Partie 3: Traitement et analyse des données obtenues à partir de
cellules test*

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Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular the different approval criteria needed for the different types of ISO documents should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see www.iso.org/directives).

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. ISO shall not be held responsible for identifying any or all such patent rights. Details of any patent rights identified during the development of the document will be in the Introduction and/or on the ISO list of patent declarations received (see www.iso.org/patents).

Any trade name used in this document is information given for the convenience of users and does not constitute an endorsement.

For an explanation on the meaning of ISO specific terms and expressions related to conformity assessment, as well as information about ISO's adherence to the WTO principles in the Technical Barriers to Trade (TBT) see the following URL: [Foreword - Supplementary information](#)

The committee responsible for this document is ISO/TC 35, *Paints and varnishes*, Subcommittee SC 9, *General test methods for paints and varnishes*.

This second edition cancels and replaces the first edition (ISO 16773-3:2009), which has been technically revised. The main changes are the following:

- a) the introductory element of the title, *Paints and varnishes*, has been omitted, because the scope is broadened to include metals and alloys and the main element of the title has been changed to: *Electrochemical impedance spectroscopy (EIS) on coated and uncoated metallic specimens*;
- b) a reference to ISO/TR 16208 for dummy cells with low impedance values (10 Ω to 1 000 Ω) has been added;
- c) a reference to ASTM G106 for the precision data of low impedance measurements has been added;
- d) a test report has been added.

ISO 16773 consists of the following parts, under the general title *Electrochemical impedance spectroscopy (EIS) on coated and uncoated metallic specimens*:

- *Part 1: Terms and definitions*
- *Part 2: Collection of data*
- *Part 3: Processing and analysis of data from dummy cells*
- *Part 4: Examples of spectra of polymer-coated and uncoated specimens*

Electrochemical impedance spectroscopy (EIS) on coated and uncoated metallic specimens —

Part 3: Processing and analysis of data from dummy cells

1 Scope

This part of ISO 16773 specifies a procedure for the evaluation of the experimental set-up used for carrying out EIS on high-impedance coated samples. For this purpose, dummy cells are used to simulate high-impedance coated samples. On the basis of the equivalent circuits described, this part of ISO 16773 gives guidelines for the use of dummy cells to increase confidence in the test protocol, including making measurements, curve fitting and data presentation.

NOTE Due to the nature of the measurements, investigations of high-impedance coated samples are more susceptible to artefacts coming from electromagnetic interferences. Therefore, this part of ISO 16773 considers the aspects for measuring high-impedance samples by using appropriate dummy cells in a Faraday cage. However, most manufacturers offer complementary dummy cells in the low and medium impedance range. This allows checking the setup in the respective low impedance range.

2 Description of the dummy cells

2.1 General

A set of four equivalent circuits (dummy cells) is used to check the overall experimental arrangement. The dummy cells are mounted separately. Two types of equivalent circuit, A and B, are used, as shown in [Figure 1](#). The specific electrical components of these four cells are given in [Table 1](#). Dummy cells with low impedance values (10 Ω to 1 000 Ω) are described in ISO/TR 16208.

NOTE In [Clause 8](#), the results of an interlaboratory test are used to evaluate the precision of this method. During the interlaboratory test, the participating laboratories also measured a fifth dummy cell consisting of an equivalent circuit of type B with unknown component values.

2.2 Components of the dummy cells

Each dummy cell consists of a combination of resistors and capacitors which are soldered directly onto a printed-circuit board (see [Figures 1](#) and [2](#)). Such networks of resistors and capacitors (equivalent circuits) are often used in work on high-impedance coated specimens.

NOTE Because of the very high overall resistance of circuits A and B, the resistor simulating the electrolyte can be neglected. Typically, the values of resistances R_1 and R_2 are above 100 M Ω whereas the electrolyte resistance is around 100 Ω to 500 Ω . As a consequence, the electrolyte resistance is not significant in this kind of EIS application.

The values of the components of the four dummy cells are chosen in accordance with the following considerations.

- Dummy cell 1 should check the input resistance as well as the input capacitance of the measurement equipment.
- Dummy cells 2 to 4 should check the capability of the evaluation software and the impedance measurement equipment to distinguish between only slightly different resistor/capacitor combinations.

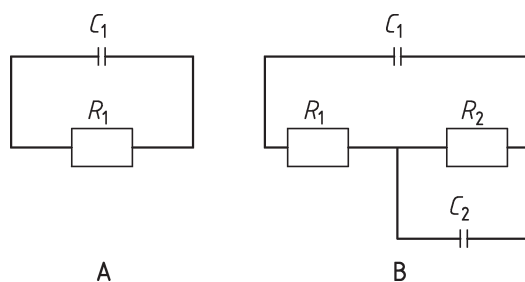


Figure 1 — Equivalent circuits of the dummy cells

Table 1 — Values of the components of the dummy cells

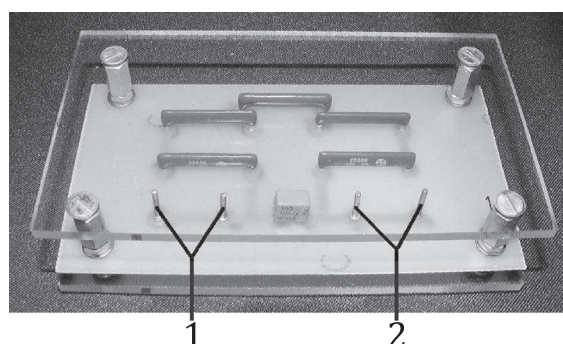
Dummy cell	Circuit	R_1 GΩ	R_2 GΩ	C_1 nF	C_2 nF
1	A	50	—	0,15	—
2	B	1	10	0,15	0,47
3	B	1	0,2	0,1	20
4	B	0,1	0,1	10	10

2.3 Accuracy requirements for the components

The accuracy required for resistors below $10^9 \Omega$ is $\pm 2 \%$ and for resistors above $10^9 \Omega$ it is $\pm 5 \%$. The accuracy required for the capacitors is $\pm 5 \%$. Such resistors and capacitors are available commercially.

2.4 Circuit description

Usually, the measurement of high-impedance coatings requires only a two-electrode set-up, but electrochemical workstations offer the possibility of connecting up three or four electrodes. To simplify the connection of the dummy cells to electrochemical workstations, each cell should have four connectors (as indicated in Figure 2), the connectors being connected internally in pairs. To avoid contamination (e.g. by fingerprints) of the printed-circuit board, each dummy cell is protected by acrylic plates mounted on top of and underneath the cell.



Key
1, 2 connector pairs

Figure 2 — Photograph of a dummy cell used in the interlaboratory test

3 Procedure

Perform all measurements in a Faraday cage in order to minimize electromagnetic interference.

NOTE The four dummy cells allow the suitability of a shielding technique (i.e. a Faraday cage) to be determined, as well as helping to find the location in the laboratory where electromagnetic noise levels are lowest.

Perform the measurements in accordance with the manufacturer's recommendations in the potentiostatic mode at a DC value of zero volts, using an amplitude of 20 mV (peak-to-zero).

A frequency range between 10^4 Hz and 10^{-2} Hz is sufficient for measurements with dummy cells 2 to 4. For dummy cell 1, a frequency range of 1 000 Hz to 5×10^{-3} Hz is recommended. About 30 min to 40 min are required for a single measurement (for dummy cell 1, about 1 h).

If the results of the measurements are not satisfactory when using an amplitude of 20 mV, increase the amplitude.

4 Data analysis

Using suitable software, e.g. that supplied by the manufacturer of the electrochemical workstation, analyse the results obtained from the dummy cell with equivalent circuit A (see [Table 1](#)). Record the result of curve fitting, the theoretical values of the circuit components and the excitation potential which was applied.

NOTE 1 Unfortunately, the curve-fitting error given for the data analysed differs from manufacturer to manufacturer, so direct comparison is not possible.

Prepare a Bode plot with the measured and simulated data.

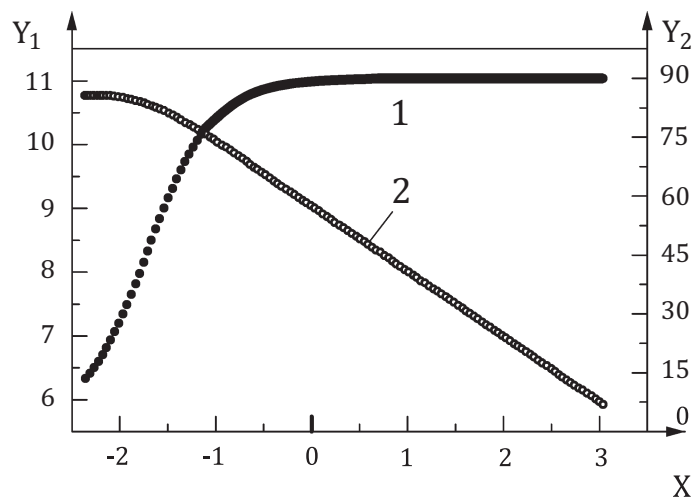
NOTE 2 Although the curve-fitting errors are not comparable, the Bode plot gives an indication of the quality of the measured data, especially at low frequencies.

Repeat the analysis with the results from cells 2 to 4 using equivalent circuit B (see [Table 1](#)).

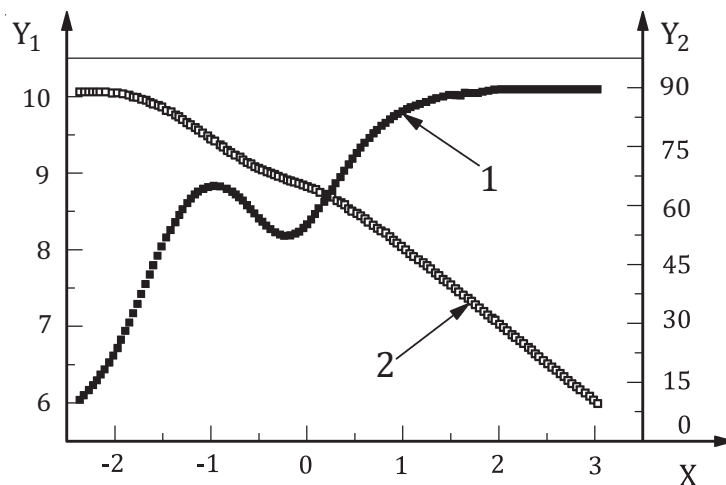
5 Presentation of the results

Present the measured data as Bode plots for comparison purposes.

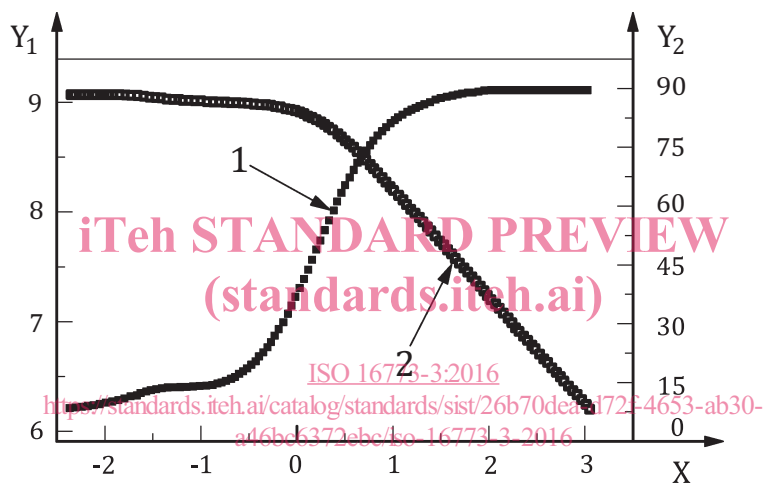
The Bode plots in [Figure 3](#) show how the dummy-cell measurements should look. These diagrams were calculated using simulation software and can be used to compare with results from dummy-cell measurements.



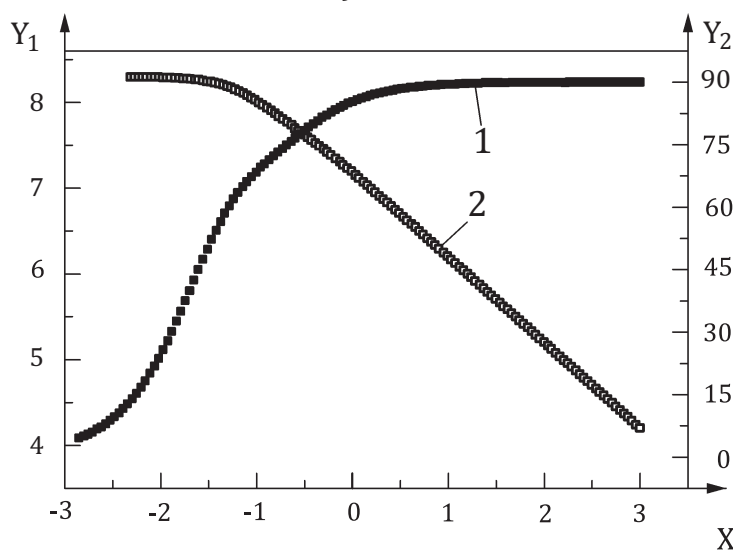
a) Cell 1



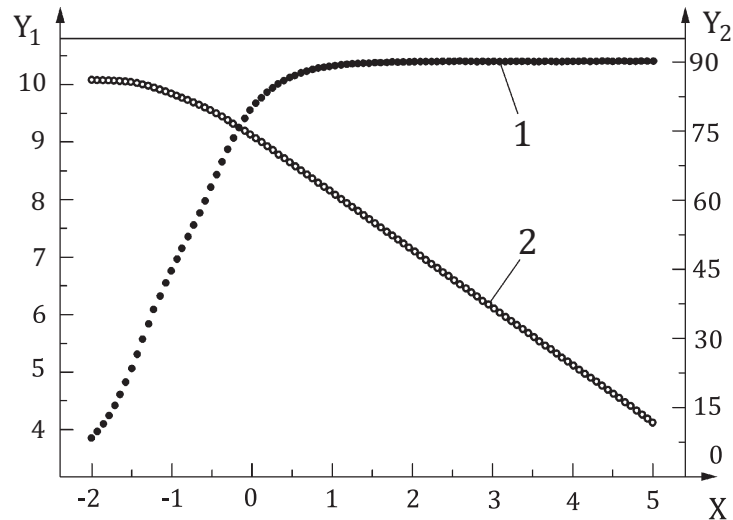
b) Cell 2



c) Cell 3



d) Cell 4



e) Cell 5 (values of components unknown)

Key

- X $\log f$ (f in Hz)
- Y_1 $\log|Z|$ (Z in Ω)
- Y_2 $|\varphi|$ (degrees)
- 1 phase angle φ
- 2 impedance Z

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Figure 3 — Bode plots of the simulated impedance spectra of the dummy cells and the unknown cell

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6 Acceptance criteria for the measurement system

The EIS system shall be capable of measuring and extracting the values of the resistors and capacitors in the dummy cells. Deviations of the fitted values of the electronic components from the real values (see [Table 1](#)) should not exceed the accuracy limits of the components used in the dummy cells. Excessive errors in the values indicate experimental problems with the EIS system or inaccurate operation of the system.

NOTE Guidance is given in ISO 16773-2.

7 Test report

If a test report is required for the documentation of dummy-cell measurements, it shall contain at least the following information:

- a) all details necessary to identify the dummy cell tested and its accuracy of electronic components;
- b) a reference to this part of ISO 16773, i.e. ISO 16773-3;
- c) the temperature and relative humidity during the conditioning and test, if different from those specified in ISO 16773-2: 2016, 6.7.2;
- d) the test method used including excitation conditions and test duration, in particular:
 - 1) frequency range, and